RCE 5.00 (5-03)

Substitute Form PTO/SB/30 (5-03 Application Number 09/774,388 Request For Filing Date January 30, 2001 Continued Examination (RCE) First Named Inventor Shunpei Yamazaki Transmittal Group Art Unit 2811 Address to Mail Stop RCE Examiner Name Thien F. Tran Commissioner for Patents P.O. Box 1450 Attorney Docket Number 07977-265001 Alexandria, VA 22313-1450

This is a Request for Continued Examination (RCE) under 37 C.F.R. §1.114 of the above-identified application.

Request for Continued Examination (RCE) practice under 37 CFR 1.114 does not apply to any utility or plant application filed prior to June 8, 1995, or to any design application. See Instruction Sheet for RCEs (not to be submitted to the USPTO) on page 2.

1. Submission required under 37 C.F.	R. §1.114 Note: If th	e RCE is	proper, ar	ny previously filed	d unentered amendments and		
amendments enclosed with the RCE w applicant does not wish to have any pr amendment(s)							
a. Previously submitted. If a final considered as a submission ex			amendmer	nt filed after the fi	nal Office action may be		
i. Consider the arguments in	the Appeal Brief or Rep	ly Brief p	reviously fi	led on			
· ii. Other							
b. 🛛 Enclosed							
i.		iii.	\boxtimes	Information Dis	sclosure Statement (IDS)		
ii.	i.						
2. Miscellaneous							
a. Suspension of action on the above period of months. (Period	e-identified application is do not be suspension shall no	s reques t exceed	ted under 3 3 months;	37 C.F.R. §1.1036 Fee under 37 C.	(c) for a F.R. §1.17(i) required)		
b.							
3. Fee The RCE fee under 37 C.F.R.	§1.17(e) is required by 3	7 C.F.R.	§1.114 wh	en the RCE is file	ed.		
a. The Director is hereby authoriz Deposit Account No. 06-1050	ed to charge the following	ng fees, o	or credit an	y overpayments,	RECEIVED JUN 10 2003 TECHNOLOGY CENTER		
 i. RCE fee required under 3° 	7 CFR 1.17(e)				00 (77		
ii. Extension of time fee (37 CFR 1.136 and 1.17)							
iii. So Other Any deficiencies b. Check in the amount of \$750 enclosed							
b. 🛛 Check in the amount of \$ <u>750</u> en	closed				IVI 21		
c. Payment by credit card (Form PT	O-2038 enclosed)						
					280		
	E OF APPLICANT, ATT				, 0		
Name (Print/Type) John F. Hayden		Registra	tion No. (A	ttomey/Agent)	37,640		
Signature	inno _	Date	July 7, 20	03			

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Shunpei Yamazaki

Art Unit : 2811

Serial No.: 09/774,388

Examiner: Thien F. Tran

Filed

: January 30, 2001

Title

: SEMICONDUCTOR DEVICE AND MANUFACTURING METHOD THEREOF

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Copies of the references listed on the attached form PTO-1449 are enclosed.

This filing is being made with the filing of a Request for Continued Examination. No fee is required.

Respectfully submitted,

Date: July 7, 2003

John F. Hayden

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Sheet	1	of	1	

Substitute Form PTO-1449	U.S. Department of Commerce Patent and Trademark Office			
Information Disclosure S	icant	Applicant Shunpei Yamazaki		
JUL 0 7 2003 (Use several shee	ts if necessary)	Filing Date January 30, 2001	Group Art Unit 2811	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,206,749	04/27/1993	Zavracky et al.			
	AB	5,317,236	05/31/1994	Zavracky et al.			
	AC	5,376,561	12/27/1994	Vu et al.			
	AD	5,654,811	08/05/1997	Spitzer et al.			
	AE	5,781,164	07/14/1998	Jacobsen et al.			
	AF	6,043,800	03/28/2000	Spitzer et al.			
	AG						
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	AJ						
	AK						
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	Foreign Patent Documents or Published Foreign Patent Applications							
Examiner	Desig.	Document	Publication	Country or			Trans	lation
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)				
Examiner	Desig.			
Initial	ID	Document		
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